# 微纳光电子材料与器件工艺原理

# Film Deposition Part III: CVD

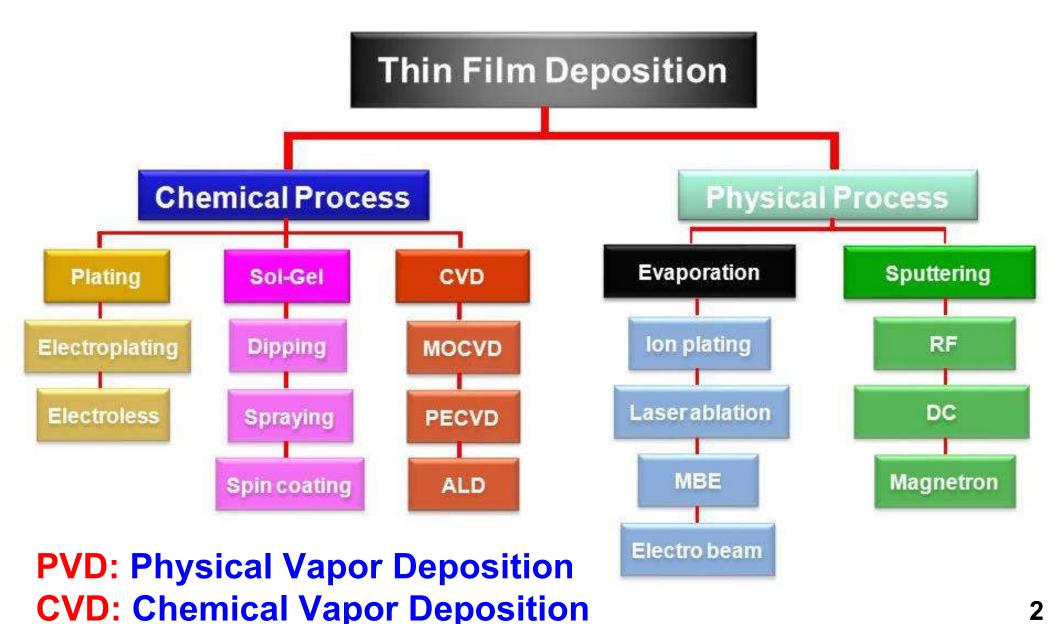
Xing Sheng 盛 兴



Department of Electronic Engineering Tsinghua University

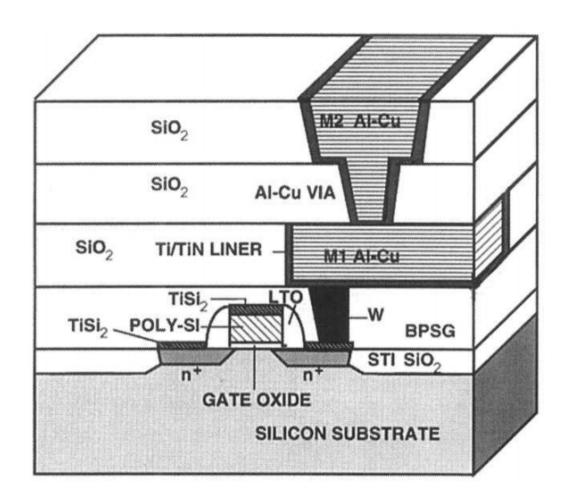
xingsheng@tsinghua.edu.cn

### Film Deposition

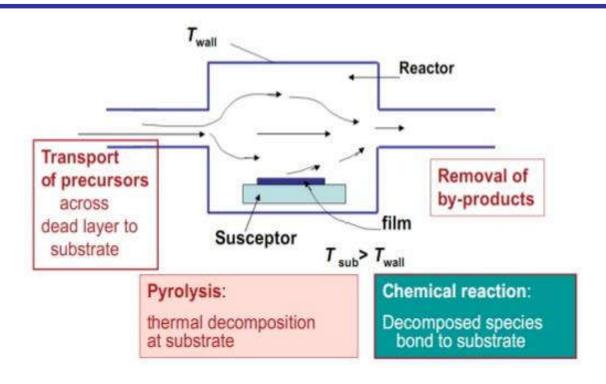


### Thin Film in CMOS

- CVD
  - □ Si
  - poly-Si
  - **□** W, SiO<sub>2</sub>, ...
- PVD
  - □ Al, Ti
  - o ...
- Electrodeposition
  - □ Cu



## **CVD: Chemical Vapor Deposition**



APCVD Atmosphere Pressure CVD

LPCVD Low Pressure CVD

UHVCVD Ultrahigh Vacuum CVD

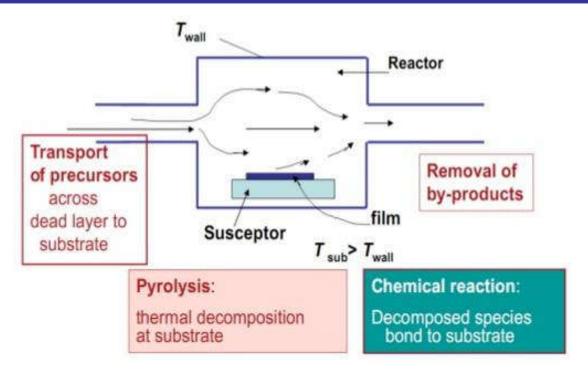
MOCVD Metal Organic CVD

PECVD Plasma Enhanced CVD

ALD Atomic Layer Deposition

\_\_\_\_

### **CVD: Chemical Vapor Deposition**



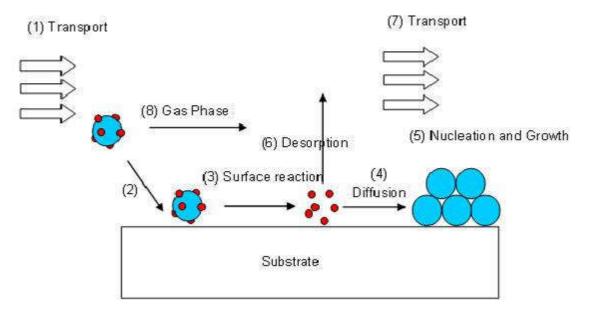
### Example:

$$SiH_4(g) = Si(s) + 2H_2(g)$$
  
 $SiH_4(g) + O_2(g) = SiO_2(s) + 2H_2(g)$ 

### **CVD**

- Process Parameters
  - Time
  - Temperature
  - Gas type
  - Gas pressure
  - Flow rate

- gas transport
- surface reaction



#### Control Parameters

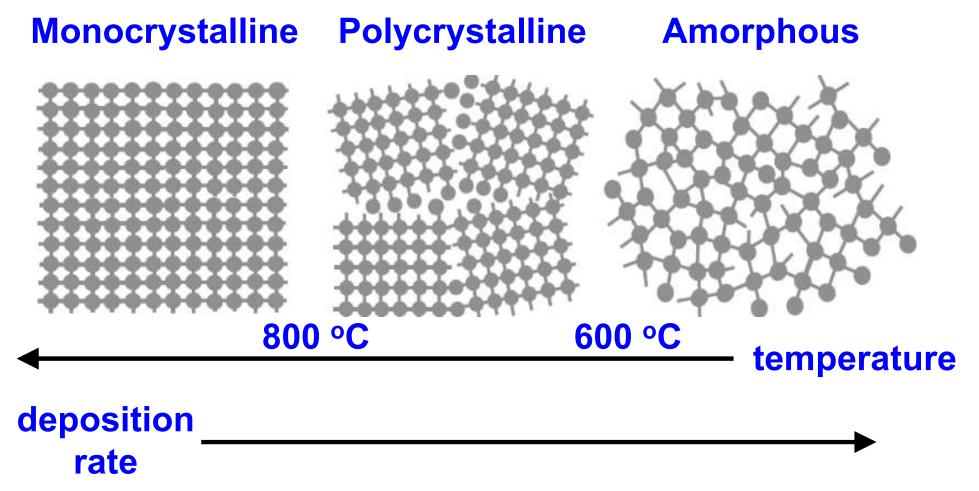
- Film thickness
- Crystallinity
- **□** Film quality (defects, dielectric strength, ...)

Q: differences between CVD and oxidation?

## Crystallinity

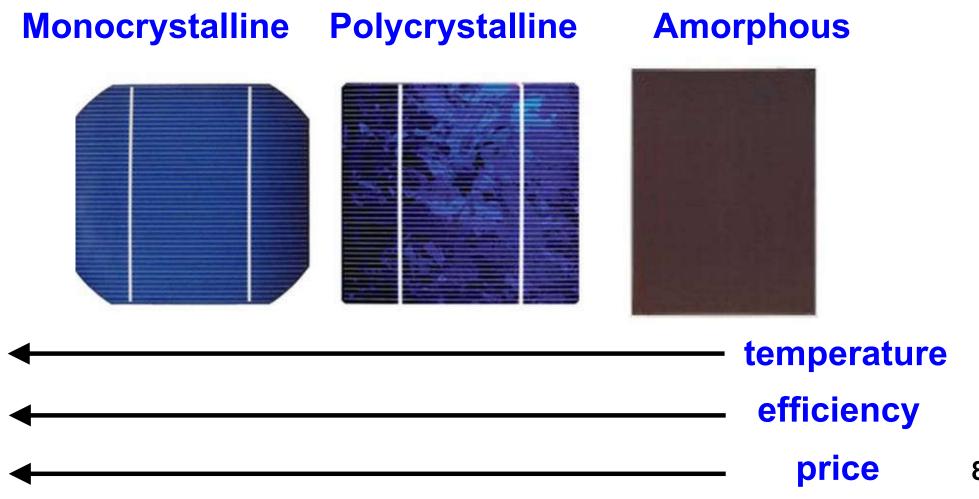
**Deposit Si on Si** 

$$SiH_4(g) = Si(s) + 2H_2(g)$$

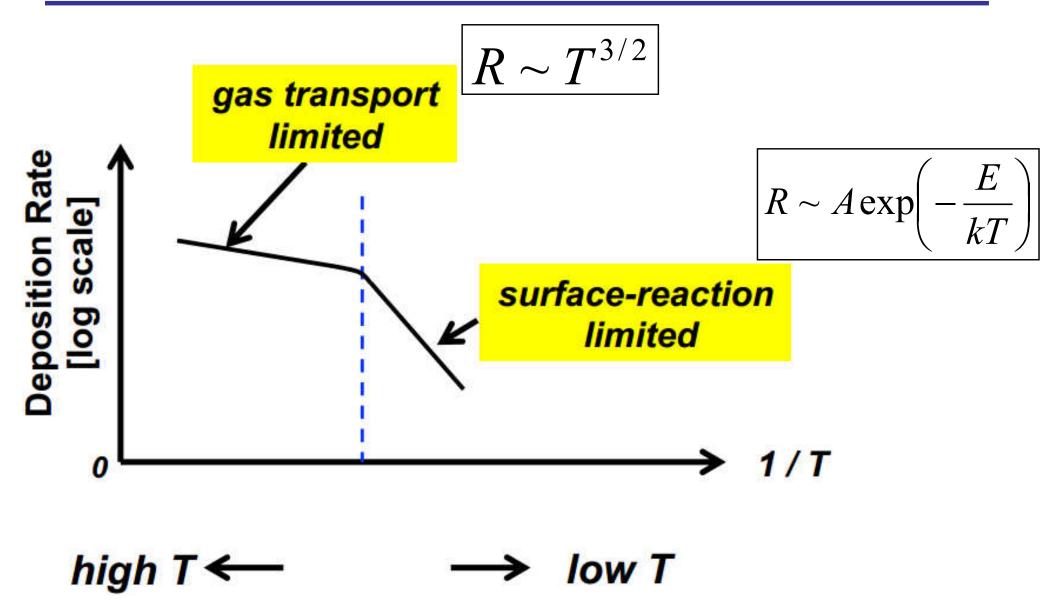


# **Crystallinity**

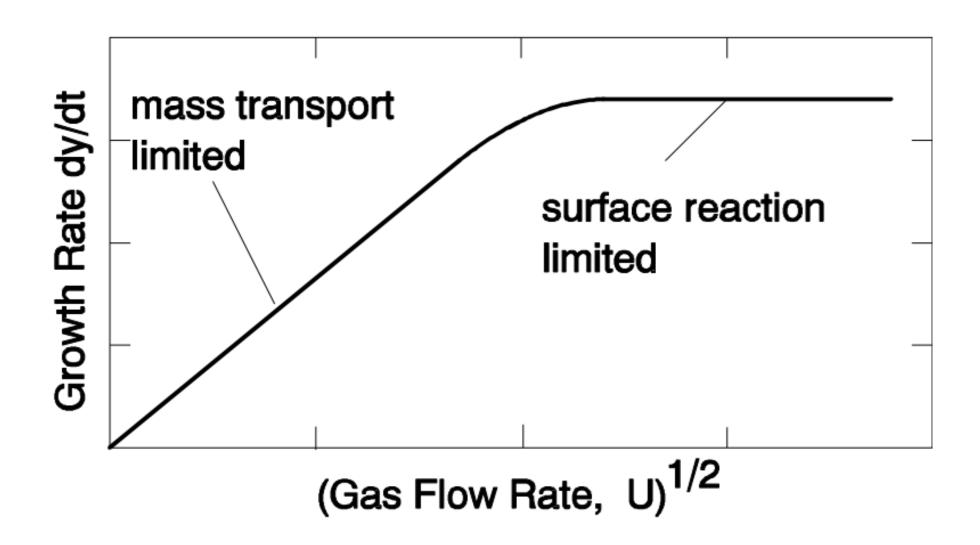
### Silicon Solar Cells



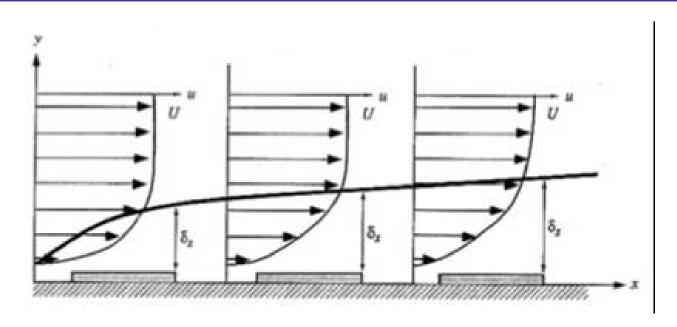
### Deposition Rate vs. Temperature

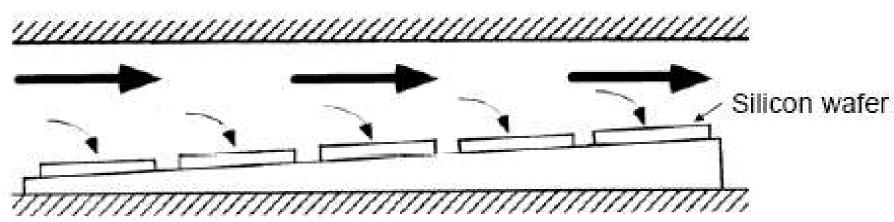


### **Deposition Rate vs. Gas Flow**



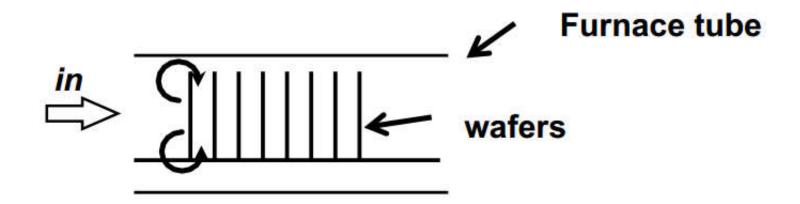
### **Issues of Gas Transport**

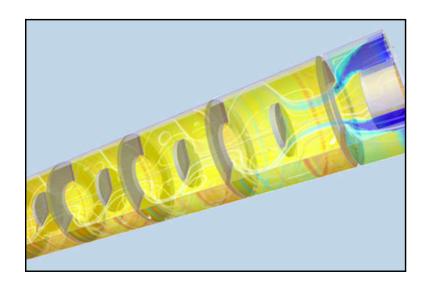


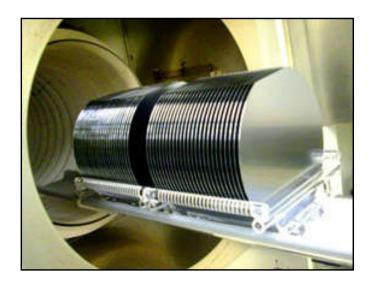


tilt the samples to improve uniformity

### **Issues of Gas Transport**



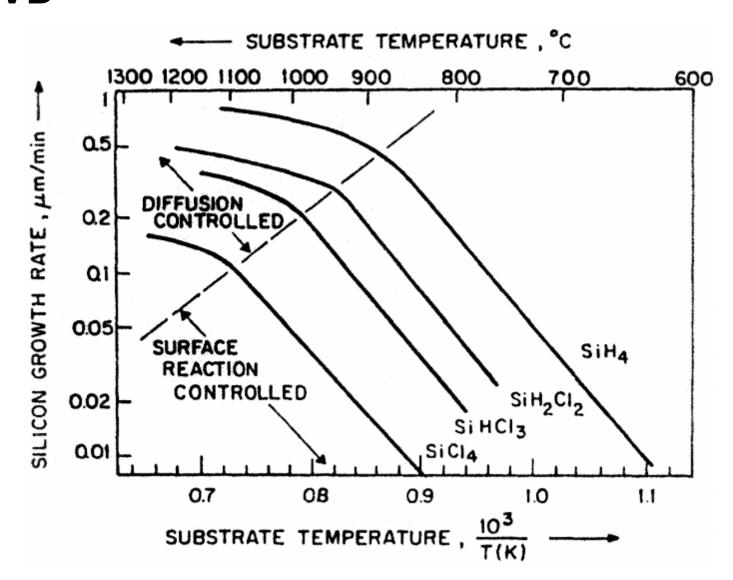




better to operate at surface reaction limited zone (low T, high flux rate)

# **Gas Types**

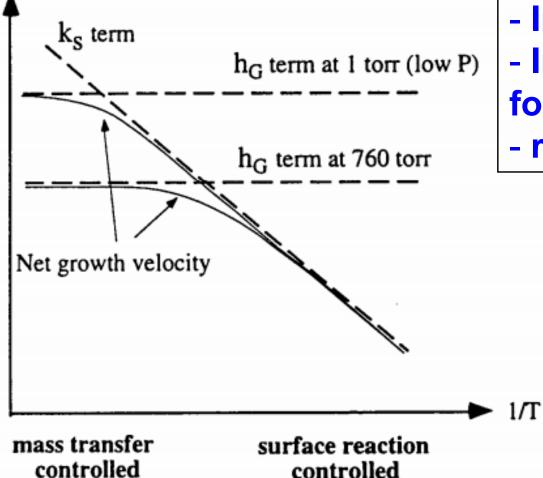
### Si CVD



### **LPCVD**

### Low Pressure CVD

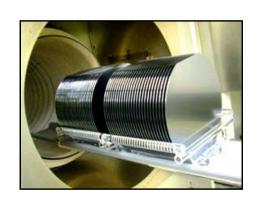
Growth velocity (log scale)



at low pressure,

- Increased rate
- Increased zone for surface reaction
- reduce cost

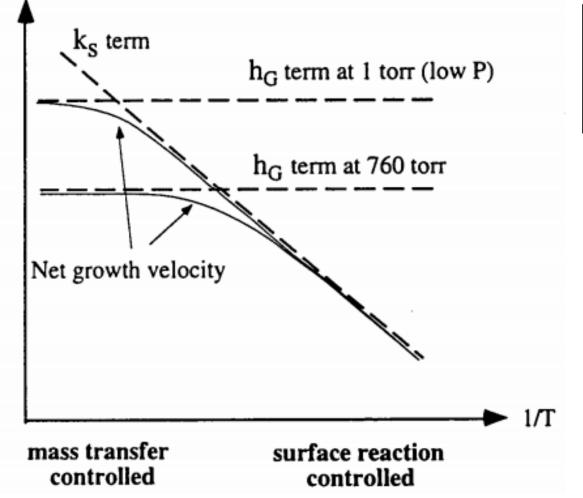
**why** ??



### **LPCVD**

### Low Pressure CVD

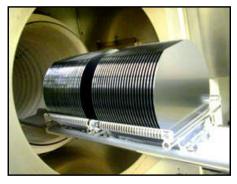
# Growth velocity (log scale)



# molecular mean free path $\lambda$

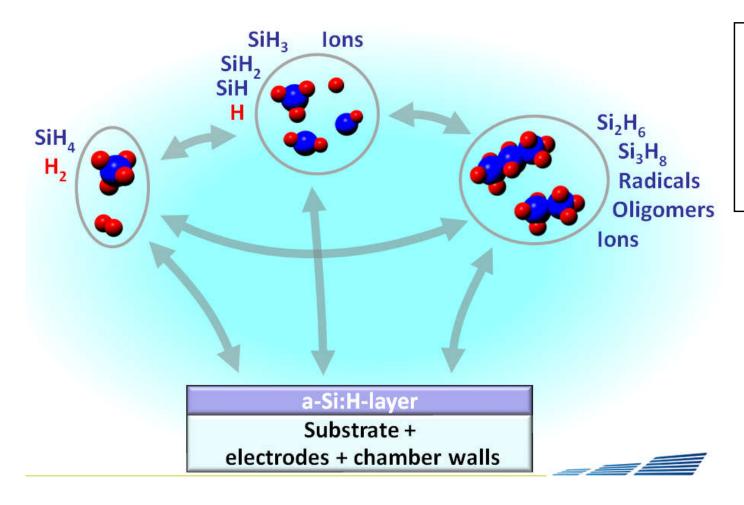
$$\lambda = \frac{kT}{\sqrt{2\pi r^2 p}}$$





### **PECVD**

### Plasma Enhanced CVD



plasma enhances the ion energy:

- higher dep. rate
- lower temperature

# SiO<sub>2</sub> Growth Methods

dry oxidation

$$\Box$$
 Si + O<sub>2</sub>

~ 1100 °C

wet oxidation

$$\Box$$
 Si + H<sub>2</sub>O

~ 1000 °C

APCVD / LPCVD

$$\Box$$
 SiH<sub>4</sub> + O<sub>2</sub>

400~600 °C

PECVD

$$\Box$$
 SiH<sub>4</sub> + N<sub>2</sub>O

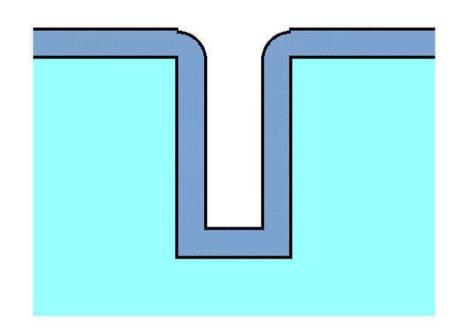
200~400 °C

- Sputter or Evaporation
  - substrate at room temperature

growth temperature

film quality

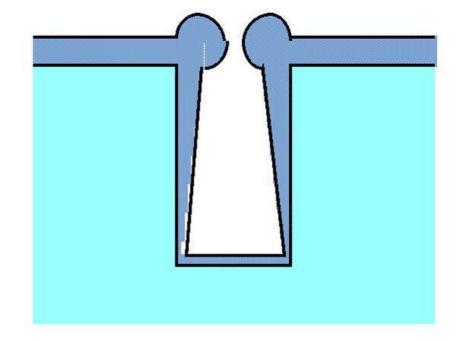
## **Step Coverage**





- LPCVD, UHVCVD, oxidation
- ALD

- ...



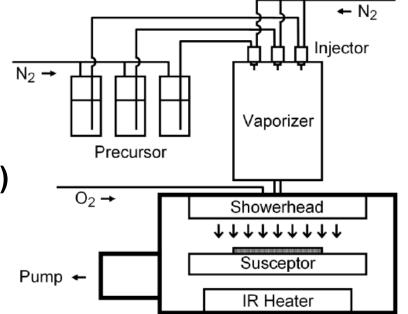
#### diffusion/transport controlled

- PECVD
- PVD (sputter, evaporation)
- \_

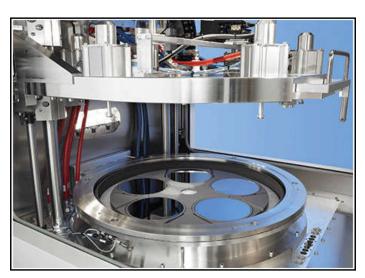
### **MOCVD**

### **Metal-Organic CVD**

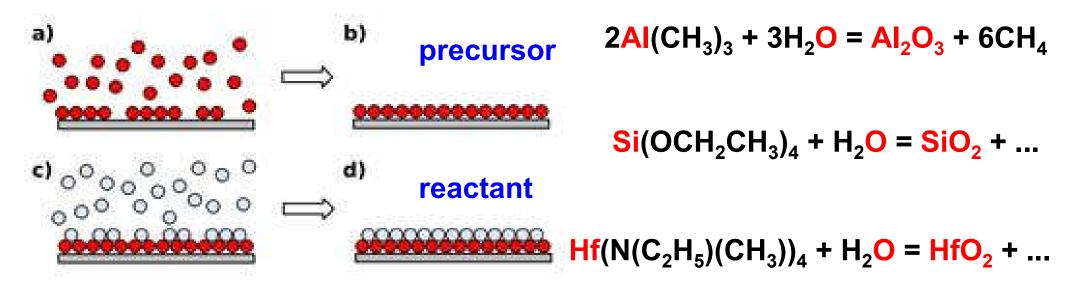
 $Ga(CH_3)_3$  (g) +  $AsH_3$  (g) = GaAs (s) +  $3CH_4$  (g)

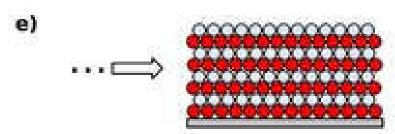


 $Ga(CH_3)_3$  (g) +  $NH_3$  (g) = GaN (s) +  $3CH_4$  (g)

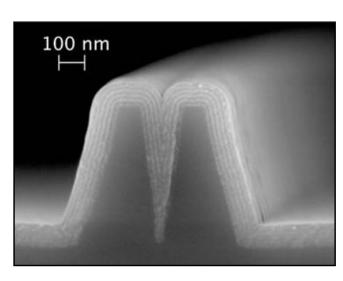


# **ALD: Atomic Layer Deposition**





- self limited growth
- layer by layer
- high uniformity
- accurate thickness control



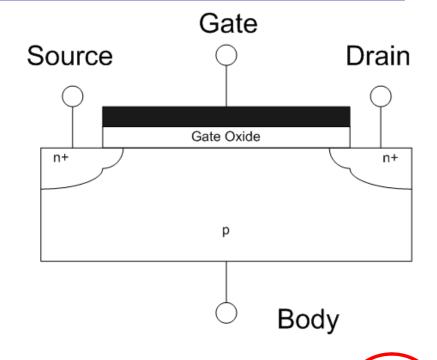
TiO<sub>2</sub> / Al<sub>2</sub>O<sub>3</sub> multilayer

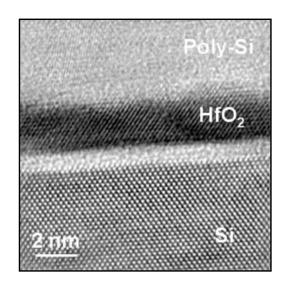
# **ALD: Atomic Layer Deposition**

$$I_{D,Sat} = \frac{W}{L} \mu C \frac{(V_G - V_{th})^2}{2}$$

$$C = \frac{\kappa \varepsilon_0 A}{t}$$

# thickness t is already $\sim$ nm high $\kappa$ -> large C -> large $I_D$

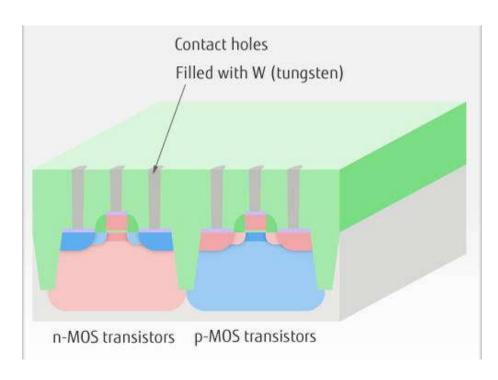




Film Type	Thermal SiO <sub>2</sub>	$Al_2O_3$	$Ta_2O_5$	$ZrO_2$	$HfO_2$
Dielectric Constant	3.95	9	26	25	25–40
Bandgap (eV)	8.9	8.7	4.5	7.8	5.7
Barrier Height to Silicon	3.2	2.8	1-1.5	1.4	1.5
Deposition Technique T	hermal Growth	CVD	CVD	CVD	CVD

### **Selective Deposition**

### **Tungsten (W) via by CVD**



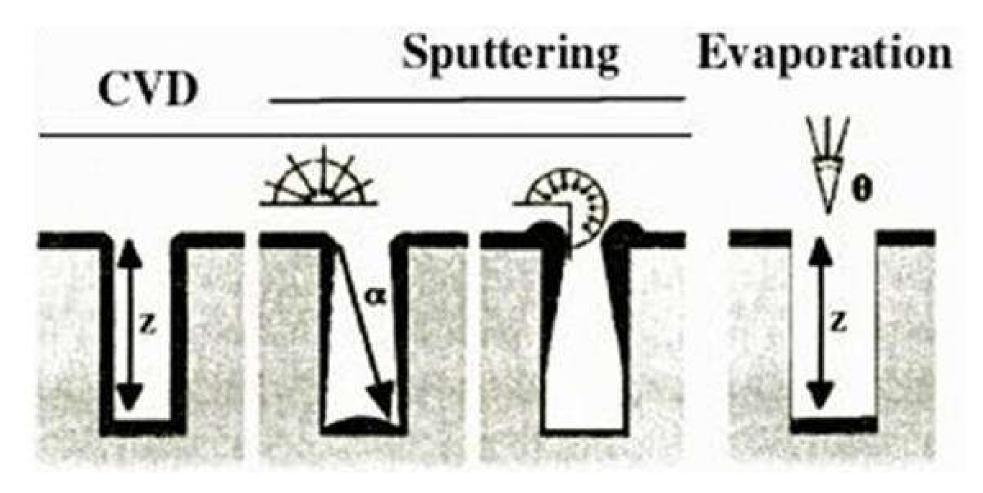
$$WF_6(g) + 3H_2(g) = W(s) + 6HF(g)$$

non-selective (everywhere)

$$2WF_6$$
 (g) + 3Si (s) =  $2W$  (s) +  $3SiF_4$  (g)  
selective, only on Si, not SiO<sub>2</sub>

Q: why do we use CVD for W vias?

# **Step Coverage**

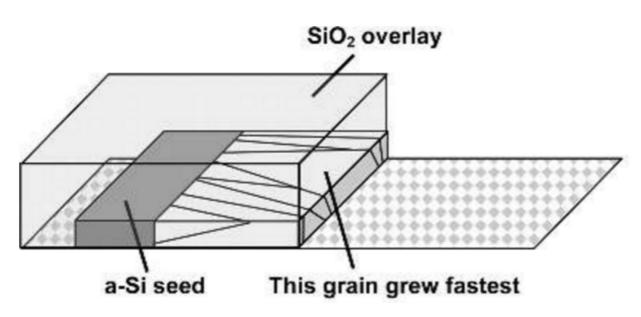


surface reaction

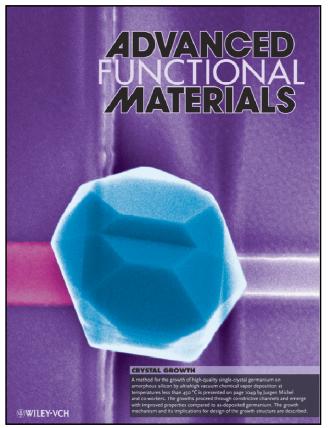
ballistic transport

### **Selective Deposition**

### Grow Ge single crystals on amorphous substrate

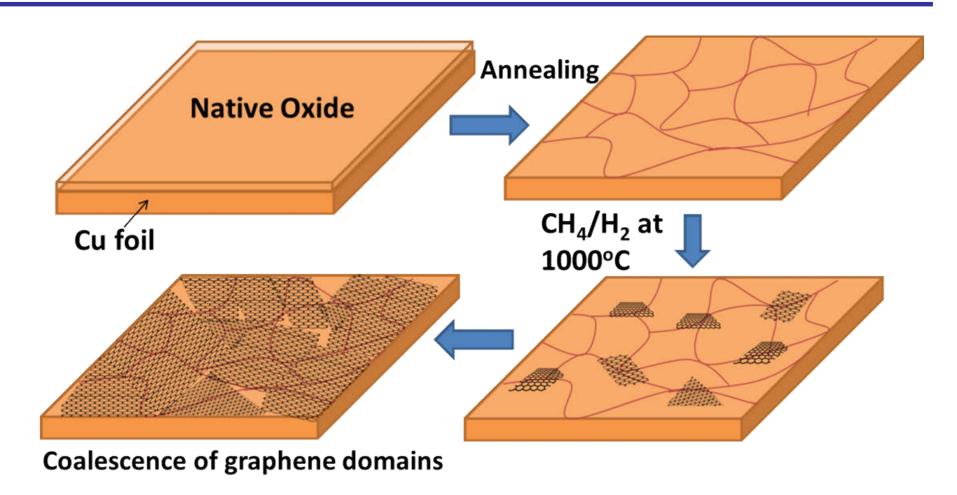


UHVCVD  $GeH_4 (g) = Ge (s) + 2H_2 (g)$ 



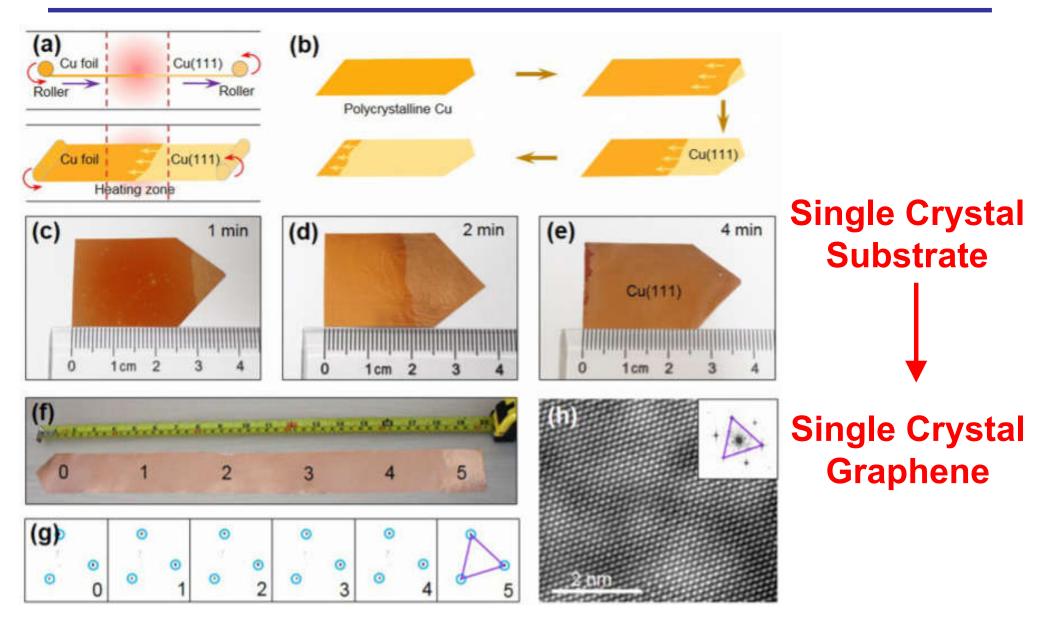
selective, only on Si, not SiO<sub>2</sub> GeO is not stable

### **Graphene by CVD**

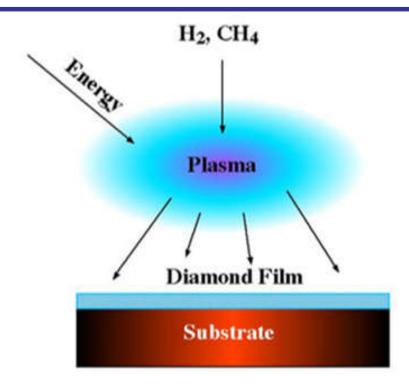


Grephene likes to nucleate at Cu grain boundaries How to get single crystal graphene?

### **Graphene by CVD**

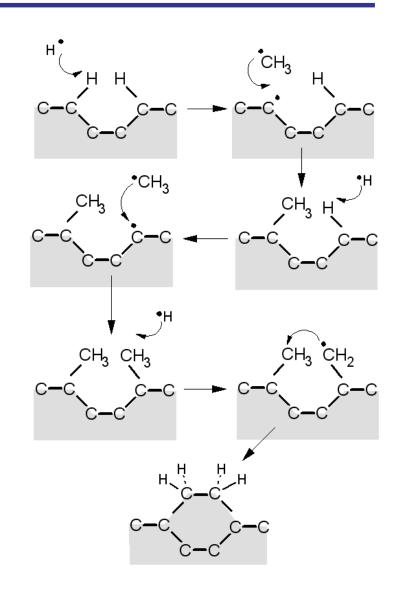


# **Diamond by CVD**









# Thank you for your attention